## **18. TEST PHOTOGRAPHS**

See following Attached Pages for setup photographs.

| FCC ID: A3LSMJ737P                  |                                      | HAC (RF EMISSIONS) TEST REPORT | SAMSUNG | Approved by:<br>Quality Manager |
|-------------------------------------|--------------------------------------|--------------------------------|---------|---------------------------------|
| Filename:<br>1M1802160028-11-R1.A3L | Test Dates:<br>3/26/2018 - 3/29/2018 | DUT Type:<br>Portable Handset  |         | Page 86 of 88                   |
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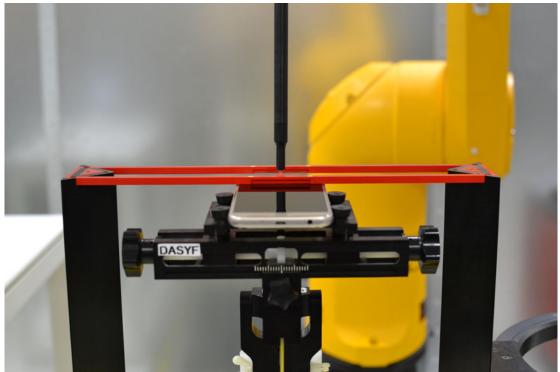


Figure 18-1 Ear Reference Point HAC Phantom Alignment

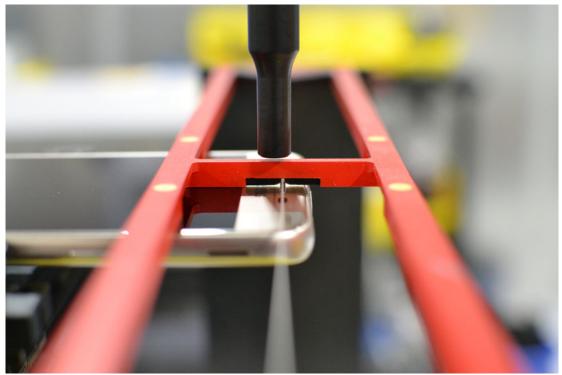
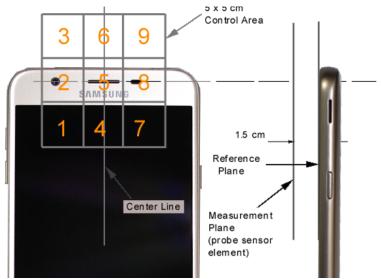


Figure 18-2 HAC Phantom Plane Alignment

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|-----------------------------|-----------------------|--------------------------------|---------|---------------------------------|
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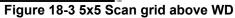




Figure 18-4 E-Field WD Scan overlay

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|------------------------------|-----------------------|--------------------------------|---------|---------------------------------|
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